

<b>Notice of References Cited</b>	Application/Control No. 10/670,743	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner John B Nguyen	Art Unit 2819	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	C	US-5,677,986	10-1997	Amada et al.	704/222
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	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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